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Thermoelectric properties and chlorine doping effect of $In_4Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x$ polycrystalline compounds

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We investigated the thermoelectric properties of Cl-doped polycrystalline compounds $\ln_4Pb_{0.01}Sn_{0.03}Se_29Cl_x$ (x = 0.02, 0.04, and 0.06). X-ray diffraction measurement shows a gradual change in lattice volume for $x \le 0.04$ without any impurity phases indicating a systemic change in Cl doping. The Cl doping in the compounds has the effect of increasing carrier concentration and the effective mass of carriers, resulting in an increase in power factor at a high temperature (~700 K). Because of the increased electrical conductivity at a high temperature, the dimensionless thermoelectric figure of merit *ZT* reaches 1.25 at 723 K for the x = 0.04 Cl-doped compound, which is a relatively high value for n-type polycrystalline materials.

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1. Introduction

The global energy crisis makes a case for not only the development of new eco-friendly energy sources but also efficient consumption of the energy currently in use. Thermoelectric research is one of the efforts made to promote energy efficiency. Thermoelectric performance can be defined by the dimensionless figure of merit $ZT = S^2 \sigma T/\kappa$, where *S*, σ , κ , and *T* are the Seebeck coefficient, electrical conductivity, thermal conductivity, and absolute temperature, respectively.

State-of-the-art thermoelectric materials have reported high ZT values of 2.6 at 923 K (SnSe)¹ and 2.2 at 915 K (SrTe-doped PbTe).² However, the materials with high recorded ZT values are mostly based on p-type materials. We need counterpart n-type materials with high thermoelectric performance in order to make thermoelectric devices.

One class of promising n-type thermoelectric materials is In_4Se_3 -based compounds. Single-crystalline In_4Se_{3-x} (x = 0.65) reported a high *ZT* value of 1.48 at 705 K using the Peierls distortion.³

Basically, because the Peierls distortion is based on quasione-dimensional electron transport, the effect of the Peierls distortion is averaged out in polycrystalline materials. Therefore, compared with single-crystalline materials, polycrystalline In₄Se_{3-x} compounds show decreased *ZT* values of 0.63 at 710 K and 0.97 at 698 K, synthesized by spark plasma sintering (SPS) and ball milling-hot press sintering methods, respectively.^{4,5}

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Recently, Pb and Sn co-doping of In_4Se_3 -based compounds produced greatly increased values of thermoelectric performances in spite of polycrystalline compounds. For example, Pb/ Sn-co-doped $In_4Pb_xSn_ySe_3$ and Se-deficient $In_4Pb_{0.01}Sn_{0.03}Se_{3-x}$ compounds exhibit relatively high *ZT* values of 1.4 at 733 K and 1.2 (x = 0.1) at 723 K, respectively.^{6,7}

The other promising route to improve thermoelectric properties in In_4Se_3 compounds is halogen doping of the compounds $In_4Se_{3-x}H_y$ (H = F, Cl, Br, and I).⁸ The Hall mobilities of single-crystalline $In_4Se_{3-x}H_{0.03}$ are significantly increased by halogen doping. It was found that Cl doping is the most effective for increasing Hall mobility. Cl-doped single-crystalline $In_4Se_{3-x}Cl_{0.03}$ (x = 0.33) exhibits high *ZT* values, with a maximum *ZT* of 1.53 at 698 K, over a wide temperature range compared with In_4Se_{3-x} .⁹ The critical issue with In_4Se_3 -based compounds is the increase in chemical potential because the materials have far from the optimum chemical potential from a Boltzmann transport calculation.^{3,9} It has been reported that multiple cation doping and halogen doping on a Se-deficient site can increase the chemical potential resulting in enhancement of thermoelectric performance.^{6,10,11}

Here, we investigate the Cl doping effect on Pb/Sn-co-doped $In_4Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x$ compounds. In the previous study, we successfully synthesized polycrystalline $In_4Pb_{0.01}Sn_{0.03}Se_{2.9}$ compounds without any impurities which exhibited a maximum *ZT* value of 1.2 at 723 K.⁷ However, the power factor of the $In_4Pb_{0.01}Sn_{0.03}Se_{2.9}$ compound can increase further,

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because it is still far from the optimized chemical potential of 0.8 eV from a Boltzmann transport calculation.^{3,9} The chemical potential of the In_4Se_3 phase can be further increased by electron doping. Cl doping is believed to be a good candidate for increasing thermoelectric performance in multiple elements-doped $In_4Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x$ compounds.

2. Experimental

Polycrystalline ingots of $In_4Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x$ (x = 0.02, 0.04, and 0.06) were synthesized by melting, quenching, and annealing processes. The elements In, Pb, Sn, and Se, and $InCl_3$ compound were sealed in evacuated quartz tubes under high vacuum with respect to their stoichiometric molar ratios. The quartz ampoules were heated at 1123 K for 24 h with subsequent water quenching.

The ingots were pulverized and sintered under an argon atmosphere by hot press at about 730 K for 1 h under uniaxial pressure of 70 MPa. In order to increase their thermal stability, the pellets were annealed at 753 K for 5 days. The relative densities of the annealed samples were above 95% (5.82–5.93 g cm⁻³) of the theoretical density.

The crystal structure and phase of the annealed samples were identified by powder X-ray diffraction (XRD) using Cu Ka radiation (D8 Advance, Bruker). Rietveld refinement was carried out using FullProf software. The electrical resistivity ρ and Seebeck coefficient S were measured under an argon atmosphere by a four-probe method using a thermoelectric properties measurement system (ZEM-3, ULVAC-RIKO, Japan). The carrier concentration was calculated by the relation $n_{\rm H}$ = $-1/(R_{\rm H}e)$ where $R_{\rm H}$ is the Hall coefficient. The Hall coefficient $R_{\rm H}$ ($R_{\rm H} = \rho_{xy}/{\rm H}$) and Hall resistivity ρ_{xy} were measured by a four-probe contact method with sweeping magnetic fields from -5 T to +5 T using a physical property measurement system (PPMS, Quantum Design, USA). We obtained the thermal conductivity from the relation $\kappa = \lambda \rho_s C_p$, where λ , ρ_s , and $C_{\rm p}$ are the thermal diffusivity, sample density, and specific heat, respectively. The thermal diffusivity λ and specific heat $C_{\rm p}$ were measured by a laser flash method (LFA-457, NETZSCH) and physical property measurement system, respectively.

3. Results and discussion

Fig. 1 shows Rietveld refinement analysis on powder X-ray diffraction (XRD) patterns of the prepared samples (x = 0.02 and x = 0.04) based on the orthorhombic *Pnnm* space group, respectively. The XRD patterns show a single phase of In₄Se₃ with no noticeable impurity peaks except for x = 0.06. Because of the impurity phase of InSe (hexagonal, no. 194), we cannot analyse the XRD pattern by Rietveld refinement for the x = 0.06 compound. This indicates that the x = 0.06 compound is at the solubility limit of chlorine which induces the phase separation from In₄Se₃ to the InSe phase. The lattice parameter was calcu-



Fig. 1 Powder X-ray diffraction profiles of $In_4Pb_{0.01}Sn_{0.03}Se_2.9Cl_x$ compounds (a) x = 0.02 and (b) x = 0.04. Reliability factors (R-factors) obtained from the fitting are as follows. x = 0.02: $R_p = 6.75$, $R_{wp} = 8.78$, $R_{exp} = 7.30$; x = 0.04: $R_p = 9.10$, $R_{wp} = 11.3$, $R_{exp} = 7.34$. The inset of (b) shows the lattice volume with respect to Cl concentration of the compounds.

Table 1 Lattice parameters of $In_4Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x$ (x = 0.0, 0.02, 0.04, and 0.06)

764
757
752
754

lated as shown in Table 1. In the previous investigation of Sedeficient Pb/Sn-co-doped compounds $In_4Pb_{0.01}Sn_{0.03}Se_{3-x}$ (x = 0.1, 0.2, 0.3, 0.4, and 0.5), the lattice parameters were systematically changed.⁷ However, the lattice parameters of the Cldoped samples $In_4Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x$ do not exhibit systematic changes but show a decrease in lattice volume (inset of Fig. 1b) with increasing chlorine concentration up to the x = 0.04 compound. Because the compound with x = 0.06 has an InSe impurity phase, the lattice volume of this compound does not exhibit systematic change.



Fig. 2 Temperature-dependent electrical resistivity $\rho(T)$ (a) and Seebeck coefficient S(T) (b) of $In_4Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x$ (x = 0.0, 0.02, 0.04, and 0.06) compounds.

From the formation energy calculations of halogen-substituted $In_4Se_{3-x}H_{0.03}$ compounds, substitution and vacancy occupation at a Se3 site by Cl doping is the most stable state in In_4Se_{3-x} .⁸ The decrease in lattice volume by Cl doping can be understood by the strong Coulomb interaction from the electronegativity of Cl and the Cl substitution at a Se3 site.¹²

The temperature-dependent electrical resistivity of polycrystalline $In_4Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x$ (x = 0.02, 0.04, and 0.06) compounds and the x = 0.0 compound⁷ is presented in Fig. 2(a). The electrical resistivity of the Cl-doped compounds exhibits semiconducting behaviour in the measured temperature range. The increasing electrical resistivity with increasing Cl doping shows similar behaviour to $In_4Se_{2.7}Cl_x$.¹⁰

The electrical resistivity is given by the relation $\rho = ne\mu$, where *n*, *e*, and μ are the Hall carrier concentration, electric charge, and Hall mobility of the carrier. From Hall resistivity ρ_{xy} and electrical resistivity ρ measurements, we obtain the effective carrier concentration $n_{\rm H}$ and Hall mobility $\mu_{\rm H}$, which are listed in Table 2. The carrier concentration of the In₄Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x (x = 0.02) compound shows a value 1.58 times higher than that of the pristine In₄Pb_{0.01}Sn_{0.03}Se_{2.9} compound. The carrier concentration does not increase with Cl doping for x = 0.04 and 0.06, implying a solubility limit of the compounds as in the case of polycrystalline In₄Se_{2.7}Cl_x compounds (x = 0-0.05).¹⁰

Table 2 Hall carrier concentration $n_{\rm H}$, electrical resistivity ρ , Hall mobility $\mu_{\rm H}$, negative Seebeck coefficient -S, and effective mass of the carriers m^* of $\ln_4 \text{Pb}_{0.01}\text{Sn}_{0.03}\text{Se}_{2.9}\text{Cl}_x$ (x = 0, 0.02, 0.04, and 0.06) compounds at 320 K

x	$n_{\rm H} \ (\times 10^{18} { m cm}^{-3})$	$ ho$ (m Ω cm)	$ { { ({\rm cm}^2 {\rm V}^{-1} {\rm s}^{-1}) } } $	$-S \ (\mu V K^{-1})$	m^* $(m_{\rm e})$
0.00	2.67	10.9	214	203	0.18
0.02	4.22	13.4	111	205	0.25
0.04	4.09	14.9	103	198	0.24
0.06	3.99	32.9	48	199	0.23

The Hall mobilities of $In_4Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x$ compounds decrease with increasing Cl doping. In contrast with the result for an $In_4Se_{3-x}Cl_{0.03}$ single crystal,⁹ the polycrystalline compounds $In_4Se_{2.7}Cl_x^{-10}$ and $In_4Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x$ exhibited a decreased Hall mobility by increasing the Cl doping. This implies that the Hall mobility of polycrystalline In_4Se_3 is decreased by excess Cl impurity scattering at the grain boundary. However, a CuBr-doped $In_4Se_{2.5}$ polycrystal shows an increased Hall mobility.¹³

The increase in Hall mobility in bulk crystalline materials is caused by an enhancement of crystallinity, *e.g.* in a chlorinedoped $In_4Se_{3-x}Cl_{0.03}$ single crystal.⁹ For example, X-ray diffraction patterns for the cross-sectional planes of crystalline ingots show well-aligned crystal orientation. However, for polycrystalline materials, the Hall mobility of chlorine-doped samples decreases with increasing chlorine doping concentration.¹⁰ This implies that the chlorine itself acts as a scattering centre of carriers but helps to enhance crystallinity during crystal growth. Doped chlorine can increase the Hall carrier density, but excess chlorine can precipitate at grain boundaries, resulting in a decrease in Hall mobility. On the other hand, singlecrystalline materials have less effect on grain boundaries, and thereby the enhanced crystallinity can increase the Hall mobility of carriers.

The temperature-dependent Seebeck coefficient S(T) of polycrystalline In₄Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x (x = 0.02, 0.04, and 0.06) compounds decreases with Cl doping as compared with the x = 0.0 compound, as shown in Fig. 2(b). The Seebeck coefficient of degenerate semiconductors can be expressed by the following equation:

$$S = \frac{8\pi^2 k_{\rm B}^2}{3eh^2} m^* T \left(\frac{\pi}{3n}\right)^{2/3}$$

where m^* and n are the effective mass of the carrier and the carrier concentration, respectively.¹⁴ From the Hall carrier concentration and the measured Seebeck coefficient, the calculated effective mass of the carrier is listed in Table 2. The effective mass of the carrier of the x = 0.02 sample has obviously increased compared with that of the x = 0.0 sample, even though the Cl doping dependence is not clear. The increased effective mass of the carrier indicates a less dispersive electron band than in the non-Cl-doped sample. From the effective thermal band gap relation, $E_{\rm g} = 2eS_{\rm max}T_{\rm max}$,¹⁵ we can



Fig. 3 Temperature-dependent total thermal conductivity κ_{tot} (closed symbols), lattice thermal conductivity κ_{ph} (a), and Lorenz number L(T) (b) of $In_4Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x$ (x = 0.0, 0.02, 0.04, and 0.06) compounds.

estimate the band gap as $0.372 \text{ eV} (x = 0.0)^7$ and 0.347 eV (x = 0.04). The Cl doping in $\text{In}_4\text{Pb}_{0.01}\text{Sn}_{0.03}\text{Se}_{2.9}\text{Cl}_x$ compounds induces a less dispersive and decreased band gap than that of the $\text{In}_4\text{Pb}_{0.01}\text{Sn}_{0.03}\text{Se}_{2.9}$ compound.

The total thermal conductivities of the polycrystalline $In_4Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x$ (x = 0, 0.02, 0.04 and 0.06) compounds are shown in Fig. 3(a). The thermal conductivities of the x = 0.0, 0.02, 0.04, and 0.06 compounds decrease with increasing temperature. This conventional 1/T behaviour is mainly caused by an acoustic phonon contribution to thermal transport. There is no systematic change in $\kappa(T)$ with respect to the Cl doping concentration.

In general, the total thermal conductivity κ is composed of electronic κ_{el} and lattice thermal conductivity κ_{ph} . The electronic thermal conductivity κ_{el} can be calculated by the Wiedemann–Franz law $\kappa_{el} = L_0 \sigma T$, where L_0 , σ , and T are the Lorenz number, electrical conductivity, and absolute temperature, respectively. In usual cases, the Lorenz number is written as:

$$L_0 = \frac{\pi^2}{3} \left(\frac{k_{\rm B}}{e} \right)^2 = 2.45 \times 10^{-8} \text{ W } \Omega \text{ K}^{-2}$$

However, the Lorenz number is incorrect in correlated metals and many degenerate semiconductors. In order to

obtain a more reliable Lorenz number, we calculated the Lorenz number using the following equation:⁷

$$L = \left(\frac{k_{\rm B}}{e}\right)^2 \left(\frac{\left(r + \frac{7}{2}\right)F_{r+\frac{5}{2}}(\eta)}{\left(r + \frac{3}{2}\right)F_{r+\frac{1}{2}}(\eta)} - \left[\frac{\left(r + \frac{5}{2}\right)F_{r+\frac{3}{2}}(\eta)}{\left(r + \frac{3}{2}\right)F_{r+\frac{1}{2}}(\eta)}\right]^2\right)$$

where *r* is the scattering parameter, $\eta = E_F/k_BT$ is the reduced Fermi energy, and $F_n(\eta)$ is the *n*th order Fermi integral given by

$$F_n(\eta) = \int_0^\infty \frac{x^n}{1 + e^{x - \eta}} dx$$

In most cases, the scattering parameter for acoustic phonon scattering is r = -1/2. When we fit the measured Seebeck coefficient to the following equation with a free parameter η , we can obtain the Fermi integral η :

$$S = \pm rac{k_{
m B}}{e} \left\{ rac{(r+rac{5}{2})F_{r+rac{3}{2}}(\eta)}{(r+rac{3}{2})F_{r+rac{1}{2}}(\eta)} - \eta
ight\}$$

Using the Fermi integral, the calculated temperature-dependent Lorenz numbers of $In_4Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x$ (x = 0.0, 0.02, 0.04, and 0.06) are shown in Fig. 3(b). The calculated temperature-dependent Lorenz number is lower than the conventional Lorenz number $L_0 = 2.45 \times 10^{-8}$ W Ω K⁻². The low Lorenz numbers indicate that the electronic contribution to thermal transport is lower than in conventional metals. Using the calculated Lorenz number and electrical resistivity, we can obtain the lattice thermal conductivity by subtracting the electronic thermal conductivity from the total thermal conductivity as shown in Fig. 3(a) (open symbols). The change in lattice thermal conductivity with respect to the chlorine doping concentration of $In_4Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x$ (x = 0.0, 0.02, 0.04, and 0.06) is not obvious. The similar thermal conductivity can be explained by the similarity of the crystal structure and phonon dispersion relation between In₄Se₃ and InSe.¹⁶

Fig. 4(a) shows the temperature-dependent power factor $S^2\sigma$ of polycrystalline In₄Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x (x = 0.0, 0.02, 0.04, and 0.06) compounds. The decreased power factor with increasing Cl doping is mainly caused by decreased Hall mobility in the room- and mid-temperature range. On the other hand, slightly increased power factors for the x = 0.02 and 0.04 compounds are obtained near 723 K. The x = 0.06 compound exhibits a decreased power factor from that of the other samples (x = 0.0, 0.02, and 0.04) implying that InSe phase separation is ineffective in increasing the power factor in the In₄Se₃ phase.

The *ZT* values of polycrystalline $In_4Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x$ (x = 0.0, 0.02, 0.04, and 0.06) compounds are presented in Fig. 4(b). The maximum *ZT*, when x = 0.04, reaches 1.25 at 723 K, which is a slightly increased value compared with that of the pristine compound x = 0.0 (ZT = 1.2). The high *ZT* value over a wide temperature range in bulk crystals of $In_4Se_{3-x}Cl_{0.03}$ (1.53) is caused by a significant increase in Hall mobility which is attributed to an enhancement of crystallinity by chlorine doping.⁹ Because the polycrystalline $In_4Se_{2.7}Cl_x$ samples exhibit a decreased *ZT* value (0.67) with increasing chlorine doping concentration, we believe that a further enhancement



Fig. 4 Temperature-dependent power factor $S^2\sigma$ (a) and ZT values (b) of In₄Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x (x = 0.0, 0.02, 0.04 and 0.06) compounds.

of *ZT* is possible in $In_4Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x$ compounds in single-crystalline form. Therefore we should investigate the thermoelectric properties of the single-crystalline compounds as further research.

4. Conclusions

Cl-doped polycrystalline $In_4Pb_{0.01}Sn_{0.03}Se_{2.9}Cl_x$ (x = 0.0, 0.02, 0.04, and 0.06) compounds are synthesized well by melting and solid-state reactions with a systematic change in lattice volume. Because of chlorine impurity scattering, the electrical resistivities of the Cl-doped samples (x = 0.02, 0.04, and 0.06) are increased as compared with the non-Cl-doped sample (x = 0.0) near room temperature, which is mainly caused by a decrease in Hall mobility by chlorine doping. However, the electrical resistivities of the x = 0.02 and 0.04 compounds are decreased at high temperature accompanied by smearing out of the broad shoulder near 670 K.

Consequently, they exhibit a relatively low thermal conductivity and high power factor over a wide temperature range. The power factor and *ZT* values of the Cl-doped compounds (x = 0.02 and 0.04) increased as compared with the non-Cl-doped compound (x = 0.0) near 700 K. The maximum *ZT* value of 1.25 is relatively high for polycrystalline In₄Se₃-based compounds. Further enhancement of thermoelectric performance can be expected in single-crystalline compounds by promoting crystallinity of the samples.

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